

BUK7C08-55AITE

N-channel TrenchPLUS standard level FET

Rev. 02 — 17 February 2009

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes

1.3 Applications

- Automotive and general purpose power switching
- Fan control

1.4 Quick reference data

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Reduced component count due to integrated current sensor
- Electrical Power Assisted Steering (EPAS)
- Variable Valve Timing for engines

| Table 1. | Quick reference | | | | | | |
|------------------------------------|--|--|-----|------|-------|-------|------|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
| V _{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | | - | - | 55 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 2;</u> see <u>Figure 3</u> | [1] | - | - | 130 | А |
| Static ch | naracteristics | | | | | | |
| R _{DSon} | drain-source on-state resistance | V_{GS} = 10 V; I_D = 50 A; T_j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u> | | - | 6.8 | 8 | mΩ |
| I _D /I _{sense} | ratio of drain current to sense current | T _j > -55 °C; T _j < 175 °C; V _{GS} > 5 V | | 450 | 500 | 550 | |
| S _{F(TSD)} | temperature sense diode temperature coefficient | I _F = 250 μA; T _j > -55 °C; T _j < 175 °C | | -1.4 | -1.54 | -1.68 | mV/K |
| V _{F(TSD)} | temperature sense diode forward voltage | I _F = 250 μA; T _j = 25 °C | | 648 | 658 | 668 | mV |
| | | | | | | | |

[1] Current is limited by power dissipation chip rating.

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N-channel TrenchPLUS standard level FET

2. Pinning information

| Table 2. | Pinning | information | | |
|----------|---------|-----------------------------------|--------------------|-----------------------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | G | gate | | d a |
| 2 | ISENSE | sense current | mb | |
| 3 | А | anode | | |
| 4 | D | drain | i i !' | |
| 5 | К | cathode | | |
| 6 | KS | Kelvin source | 123 567 | |
| 7 | S | source | SOT427 | MBL362 Isense Kelvin source |
| mb | D | mounting base; connected to drain | (D2PAK) | MDL302 SEI13E KEIVIII SUUCE |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|----------------|---------|--|---------|
| | Name | Description | Version |
| BUK7C08-55AITE | D2PAK | plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped) | SOT427 |

4. Limiting values

Table 4. Limiting values

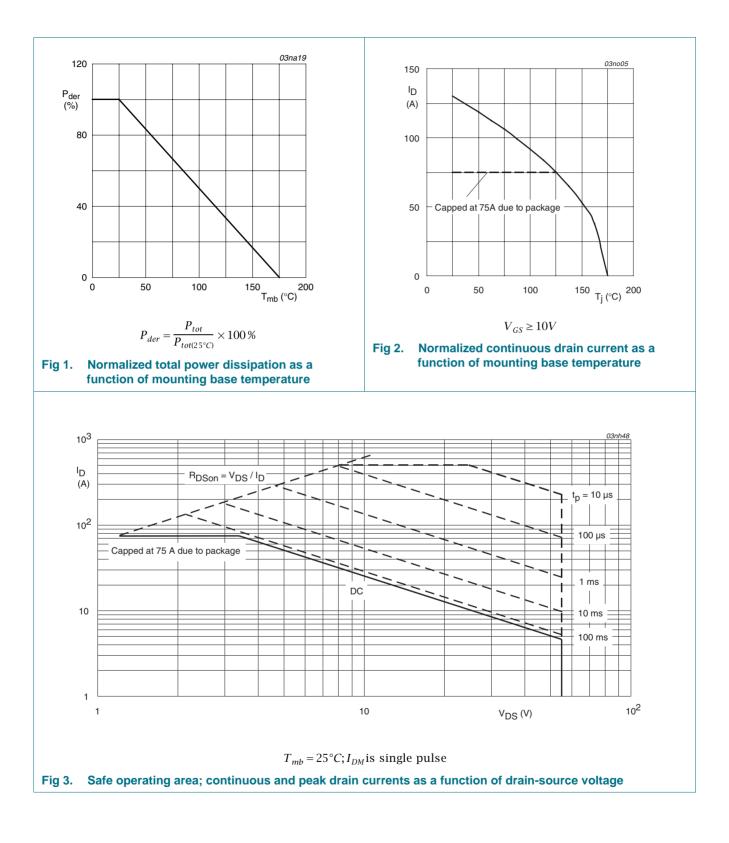
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|----------------------|--|---|-----|------|-----|------|
| V _{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | | - | 55 | V |
| V _{DGR} | drain-gate voltage | $R_{GS} = 20 \text{ k}\Omega$ | | - | 55 | V |
| V _{GS} | gate-source voltage | | | -20 | 20 | V |
| I _D | drain current | T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 2</u> ; | [1] | - | 130 | А |
| | | see Figure 3 | [2] | - | 75 | А |
| | | T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u> | [2] | - | 75 | А |
| I _{DM} | peak drain current | $T_{mb} = 25 \text{ °C}; t_p \le 10 \mu\text{s}; \text{ pulsed}; \text{ see } \frac{\text{Figure } 3}{10 \mu\text{s}}$ | | - | 522 | А |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 1</u> | | - | 272 | W |
| I _{GS(CL)} | gate-source clamping | continuous | | - | 10 | mA |
| | current | pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$ | | - | 50 | mA |
| $V_{isol(FET-TSD)}$ | FET to temperature sense diode isolation voltage | | | -100 | 100 | V |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| Tj | junction temperature | | | -55 | 175 | °C |
| Source-drain | n diode | | | | | |
| I _S | source current | T _{mb} = 25 °C | [1] | - | 130 | А |
| | | | [2] | - | 75 | А |
| I _{SM} | peak source current | $t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$ | | - | 522 | А |
| Avalanche ru | uggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | $\begin{split} I_D = 75 \text{ A}; V_{sup} \leq 55 \text{ V}; \text{R}_{GS} = 50 \Omega; \text{V}_{GS} = 10 \text{ V}; \\ T_{j(\text{init})} = 25 ^{\circ}\text{C}; \text{ unclamped} \end{split}$ | | - | 460 | mJ |
| Electrostatic | discharge | | | | | |
| V _{esd} | electrostatic discharge voltage | HBM; C = 100 pF; R = 1.5 k Ω | | - | 6 | kV |

[1] Current is limited by power dissipation chip rating.

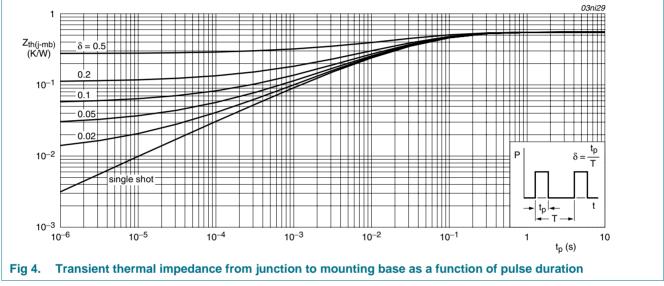
[2] Continuous current is limited by package.

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5. Thermal characteristics

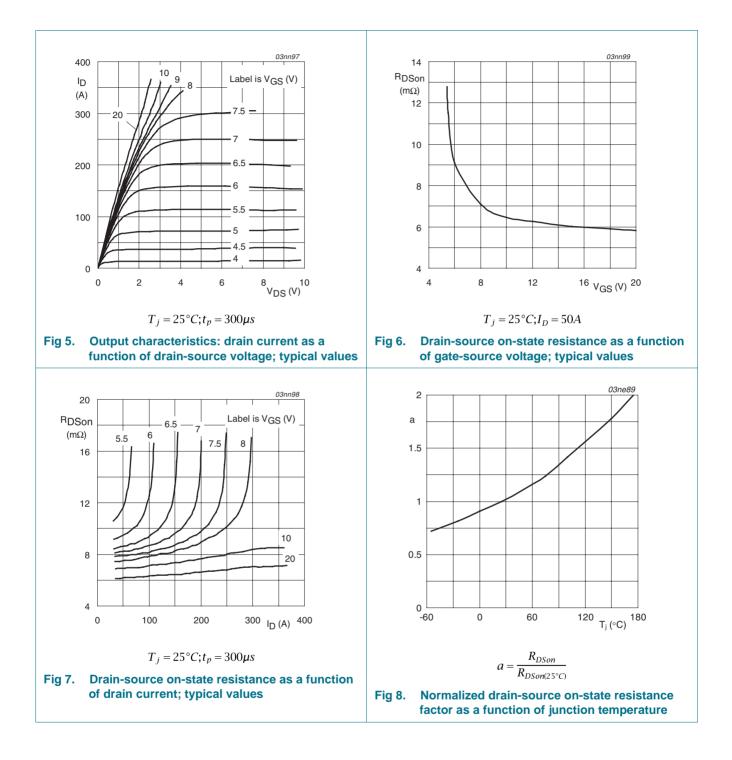
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---|--|-----|-----|------|------|
| R _{th(j-a)} | thermal resistance from junction to ambient | mounted on printed-circuit board; minimum footprint | - | - | 50 | K/W |
| R _{th(j-mb)} | thermal resistance from junction to mounting base | see Figure 4 | - | - | 0.55 | K/W |



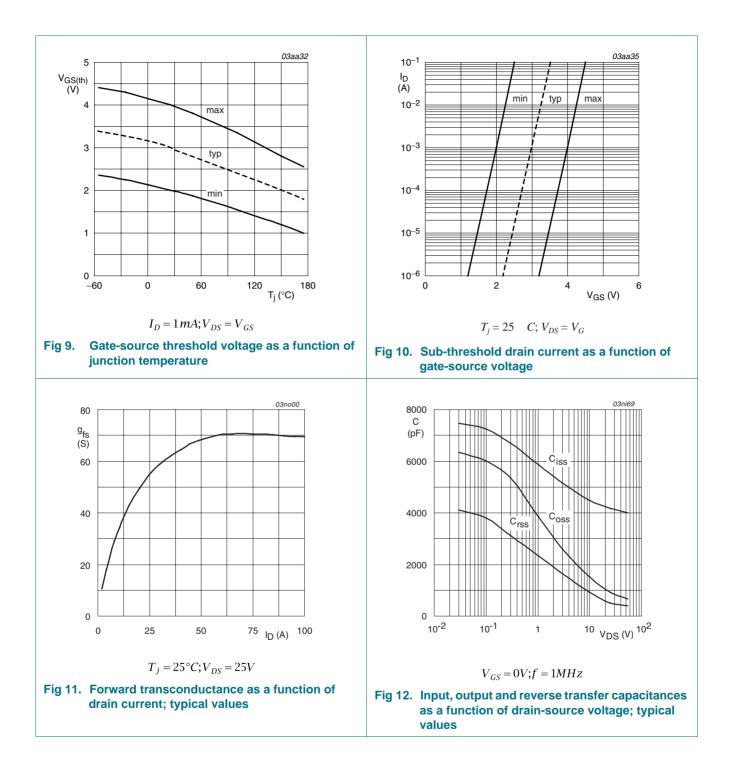
6. Characteristics

| Table 6. | Characteristics | | | | | |
|---|--|---|------|-------|-------|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| Static char | acteristics | | | | | |
| V _{(BR)DSS} | drain-source | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | 55 | - | - | V |
| | breakdown voltage | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$ | 50 | - | - | V |
| V _{GS(th)} | gate-source threshold voltage | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 9 | 2 | 3 | 4 | V |
| | | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 9 | 1 | - | - | V |
| | | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see Figure 9 | - | - | 4.4 | V |
| I _{DSS} | drain leakage current | V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C | - | 0.1 | 10 | μΑ |
| | | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$ | - | - | 250 | μΑ |
| V _{(BR)GSS} | gate-source breakdown voltage | $I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$ | 20 | 22 | - | V |
| | | I_G = -1 mA; V_{DS} = 0 V; T_j > -55 °C; T_j < 175 °C | 20 | 22 | - | V |
| I _{GSS} | gate leakage current | $V_{DS} = 0 V; V_{GS} = 10 V; T_j = 25 °C$ | - | 22 | 1000 | nA |
| | | V _{DS} = 0 V; V _{GS} = -10 V; T _j = 25 °C | - | 22 | 1000 | nA |
| | | V _{DS} = 0 V; V _{GS} = 10 V; T _j = 175 °C | - | - | 10 | μA |
| | | V _{DS} = 0 V; V _{GS} = -10 V; T _j = 175 °C | - | - | 10 | μA |
| R _{DSon} drain-source on-s resistance | drain-source on-state resistance | V _{GS} = 10 V; I _D = 50 A; T _j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u> | - | 6.8 | 8 | mΩ |
| | | V_{GS} = 10 V; I_D = 50 A; T_j = 175 °C; see Figure 7; see Figure 8 | - | - | 16 | mΩ |
| R _{(D-ISENSE)on} drain-ISENSE on-state resistance | | V_{GS} = 10 V; I _D = 25 mA; T _j = 25 °C; see <u>Figure 18</u> | 1.32 | 1.55 | 1.82 | Ω |
| | | V_{GS} = 10 V; I _D = 25 mA; T _j = 175 °C; see Figure 18 | 3.04 | 3.57 | 4.19 | Ω |
| V _{F(TSD)} | temperature sense diode forward voltage | $I_F = 250 \ \mu A; \ T_j = 25 \ ^\circ C$ | 648 | 658 | 668 | mV |
| S _{F(TSD)} | temperature sense diode temperature coefficient | I _F = 250 μA; T _j > -55 °C; T _j < 175 °C | -1.4 | -1.54 | -1.68 | mV/K |
| V _{F(TSD)hys} | temperature sense diode forward voltage hysteresis | $I_F > 125 \ \mu A; I_F < 250 \ \mu A; T_j = 25 \ ^\circ C$ | 25 | 32 | 50 | mV |
| I _D /I _{sense} | ratio of drain current to sense current | V _{GS} > 5 V; T _j > -55 °C; T _j < 175 °C | 450 | 500 | 550 | |
| Dynamic c | haracteristics | | | | | |
| Q _{G(tot)} | total gate charge | $I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 10 \text{ V};$ | - | 116 | - | nC |
| Q _{GS} | gate-source charge | | - | 19 | - | nC |
| Q _{GD} | gate-drain charge | | - | 51 | - | nC |

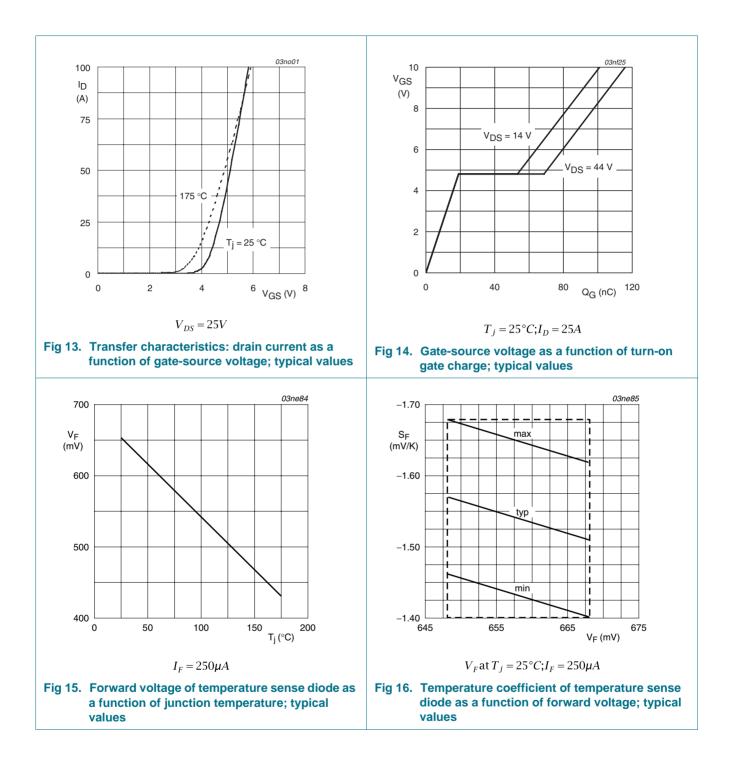
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|-------------------------------|---|-----|------|-----|------|
| C _{iss} | input capacitance | $V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$ | - | 4200 | - | pF |
| C _{oss} | output capacitance | $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 12}{\text{Figure } 12}$ | - | 920 | - | pF |
| C _{rss} | reverse transfer capacitance | | - | 500 | - | pF |
| t _{d(on)} | turn-on delay time | V_{DS} = 30 V; R_L = 1.2 Ω; V_{GS} = 10 V; | - | 35 | - | ns |
| t _r | rise time | $R_{G(ext)} = 10 \Omega; T_j = 25 °C$ | - | 115 | - | ns |
| t _{d(off)} | turn-off delay time | | - | 155 | - | ns |
| t _f | fall time | | - | 110 | - | ns |
| L _D | internal drain inductance | measured from upper edge of drain mounting base to centre of die; $T_j = 25 ^{\circ}\text{C}$ | - | 2.5 | - | nH |
| L _S | internal source inductance | measured from source lead to source bond pad; $T_j = 25 \text{ °C}$; lead length 6 mm | - | 7.5 | - | nH |
| Source-dra | ain diode | | | | | |
| V _{SD} | source-drain voltage | I _S = 40 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 19</u> | - | 0.85 | 1.2 | V |
| t _{rr} | reverse recovery time | I_S = 20 A; dI_S/dt = -100 A/µs; V_{GS} = -10 V; | - | 80 | - | ns |
| Q _r | recovered charge | V _{DS} = 30 V; T _j = 25 °C | - | 200 | - | nC |



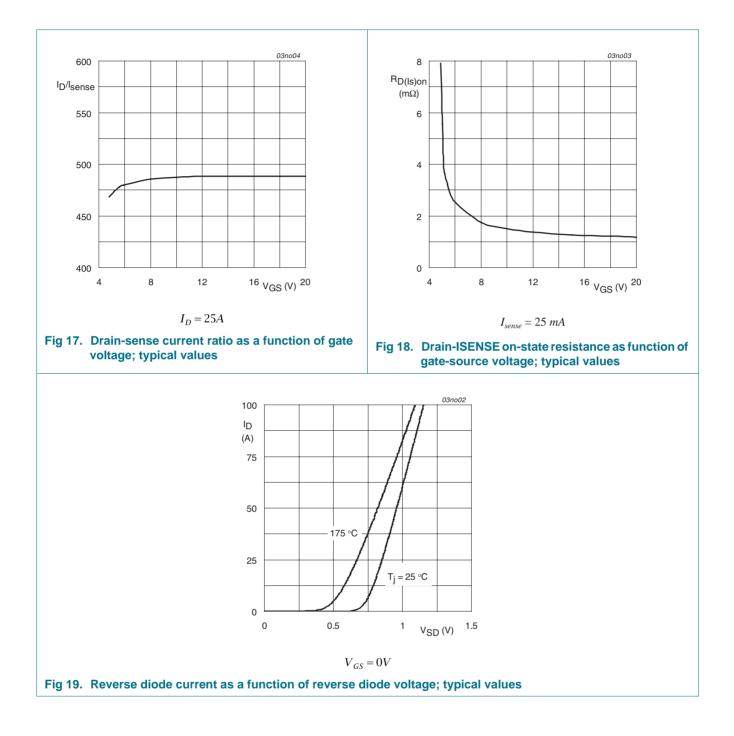
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7. Package outline

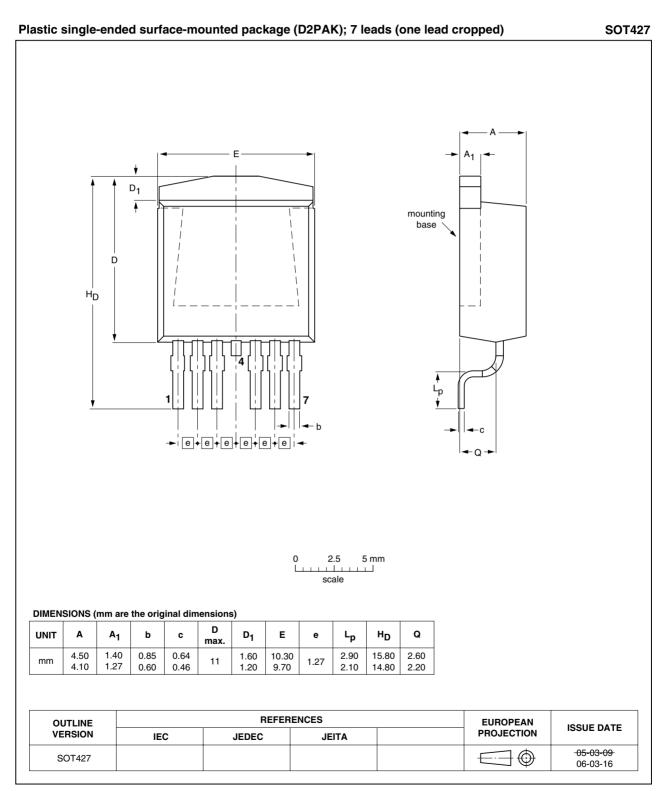


Fig 20. Package outline SOT427 (D2PAK)

8. Revision history

| Table 7. Revision his | tory | | | |
|---------------------------------------|---------------------------------|--|-------------------------|-----------------------|
| Document ID | Release date | Data sheet status | Change notice | Supersedes |
| BUK7C08-55AITE_2 | 20090217 | Product data sheet | - | BUK7C08_55AITE-01 |
| Modifications: | | of this data sheet has been of NXP Semiconductors. | en redesigned to comply | with the new identity |
| | Legal texts | have been adapted to the | new company name w | here appropriate. |
| BUK7C08_55AITE-01 (9397 750 11696) | 20030819 | Product data sheet | - | - |

9. Legal information

9.1 Data sheet status

| Document status [1][2] | Product status ^[3] | Definition |
|--------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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